

Form PTO-1449 (Rev. 8-83)		U.S. Department of Commerce		Atty. Docket No. CS-21,274-3		Serial No.	
Information Disclosure Citation (Use several sheets if necessary)				Applicant Dudovicz			
				Filing Date		Group	

U.S. PATENT DOCUMENTS													
Examiner Initial		Document Number						Date	Name	Class	Subclass	Filing Date if Appropriate	
GN ↑ ↓ GN				2	7	8	1	7	4/1860	Mayall	51	297	
				8	1	9	8	6	9/1868	Crane	431	538	
		4	1	0	9	5	4	3	8/1978	Foti	74	231	
		4	2	8	2	0	1	1	8/1981	Terpay	51	298	
		4	4	3	7	2	6	9	3/1984	Shaw	51	358	
		4	4	7	8	6	1	0	10/1984	Parekh et al.	51	298	
		4	5	2	0	0	5	9	5/1985	Worrall et al.	428	109	
		4	5	7	6	6	1	2	3/1986	Shukla et al.	51	298	
		4	6	4	9	0	7	4	3/1987	Borel	428	222	
		4	7	2	8	5	5	2	3/1988	Jensen, Jr.	428	91	
	4	7	5	3	8	3	8	6/1988	Kimura et al.	428	91		

FOREIGN PATENT DOCUMENTS														
		Document Number						Date	Country	Class	Subclass	Translation		
												Yes	No	
GN ↓ GN	6	3	2	6	7	1	5	5	11/1988	Japan				X
		9	6	1	6	4	3	6	5/1996	WO				
			6	9	6	4	9	5	10/1999	EP				
		9	8	3	6	4	4	2	8/1998	WO				

Other Documents (including Author, Title, Date, Pertinent Pages, Etc.)	
GN	Fynn et al., "The Cutting and Polishing of Electro-optic Materials" (John Wiley and Sons, 1979) pp 82-83

Examiner 	Date Considered 7/8/04
--------------	---------------------------

* EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO-1449 (Rev. 8-83)		U.S. Department of Commerce		Any. Docket No. CS-21,274-3		Serial No.								
Information Disclosure Citation (Use several sheets if necessary)				Applicant Dudovicz										
				Filing Date		Group								
U.S. PATENT DOCUMENTS														
Examiner Initial		Document Number							Date	Name	Class	Subclass	Filing Date if Appropriate	
SN ↓ ✓ SN		4	7	9	6	7	4	9	1/1989	Lefferts	198	851		
		4	8	4	1	6	8	0	6/1989	Hoffstein et al.	51	283R		
		4	9	2	7	4	3	2	5/1990	Budinger et al.	51	298		
		4	9	5	4	1	4	1	9/1990	Takiyama et al.	51	296		
		4	9	6	2	5	6	2	10/1990	Englund et al.	15	230.16		
		5	0	2	0	2	8	3	6/1991	Tuttle	51	209DL		
		5	1	6	4	2	4	1	11/1992	Andre De La Porte et al.	428	97		
		5	1	7	7	9	0	8	1/1993	Tuttle	51	283R		
		5	1	9	7	9	9	9	3/1993	Thomas	51	298		
		5	2	1	2	9	1	0	5/1993	Breivogel et al.	51	398		
	5	2	3	4	8	6	7	8/1993	Schultz et al.	437	225			
FOREIGN PATENT DOCUMENTS														
		Document Number							Date	Country	Class	Subclass	Translation	
													Yes	No
SN SN		9	8	3	5	7	8	5	8/1998	WO				
		9	8	3	5	7	8	6	8/1998	WO				
Other Documents (including Author, Title, Date, Pertinent Pages, Etc.)														
Examiner										Date Considered 7/9/04				
<small>* EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>														

Form PTO-1449 (Rev. 8-83)		U.S. Department of Commerce		Atty. Docket No. CS-21,274-3		Serial No.								
Information Disclosure Citation (Use several sheets if necessary)				Applicant Dudovicz										
				Filing Date		Group								
U.S. PATENT DOCUMENTS														
Examiner Initial		Document Number							Date	Name	Class	Subclass	Filing Date if Appropriate	
GN ↓ GN		5	5	7	3	8	4	4	11/1996	Donovan et al.	428	240		
		5	5	7	5	7	0	7	11/1996	Talich et al.	451	173		
		5	5	7	8	3	6	2	11/1996	Reinhardt et al.	428	147		
		5	6	0	5	7	6	0	2/1997	Roberts	428	409		
		5	6	9	2	9	4	7	12/1997	Talich et al.	451	41		
		5	7	3	5	7	3	1	4/1998	Lee	451	143		
		6	3	2	8	6	4	2	12/2001	Pant et al.	451	307		
FOREIGN PATENT DOCUMENTS														
		Document Number							Date	Country	Class	Subclass	Translation Yes No	
Other Documents (including Author, Title, Date, Pertinent Pages, Etc.)														
Examiner <i>[Signature]</i>										Date Considered <i>7/9/04</i>				
<small>* EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>														